


<b>Search Notes</b>  	<b>Application/Control No.</b>  09972229	<b>Applicant(s)/Patent Under Reexamination</b>  WEE ET AL.
	<b>Examiner</b>  Shiferaw, Eleni A	<b>Art Unit</b>  2136

SEARCHED			
Class	Subclass	Date	Examiner
380	37	9/6/07	ES
380	200	12/27/04	ES
380	267	9/6/07	ES
380	217	9/6/07	ES

SEARCH NOTES		
Search Notes	Date	Examiner
East searched and updated on 5/13/05, 11/1/05, 3/6/05, and 9/7/07	12/27/04	es
NPL: IEEE ((progressive image metadata) (different encryption method metadata)) •	5/13/05	es
380/201 and text searched	9/7/07	es

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
380	37, 200, 201, 217, and 269	9/7/07	es
please see the searched report attached for interference searched on class/subclasses and text searched		9/7/07	es